

***Judul:***

Test and diagnosis of analogue, mixed-signal and RF integrated circuits:  
the system on chip approach

***Pengarang/Penulis:***

***Subjek:***

Linear integrated circuits -- Testing; Mixed signal circuits -- Testing;  
Radio frequency integrated circuits -- Testing

***Nomor Panggil:***

e20452172

***Penerbitan:***

Institution of Engineering and Technology

***Link Terkait:***

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